TOSHIBA Intelligent Power Device Silicon Monolithic Power MOS IC

TPD2004F

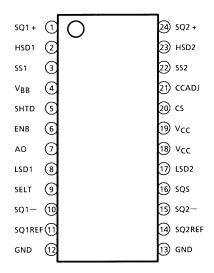
2-channel Squib Driver for Air Bags

Manufactured through the Bi-CMOS-DMOS process, this 2-channel squib drive IPD is designed for use in SRS electronic system air bags.

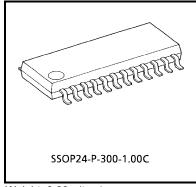
Features

- Using independent four-channel inputs, this IC controls two high-side and two low-side switches, making it possible to drive two squibs directly.
- Incorporates various diagnostic functions (analog multiplexer outputs):
 - · Squib short-to-battery diagnosis
 - Squib short-to-ground diagnosis
 - · Squib open-circuit diagnosis
 - Safing sensor-ON fault diagnosis
 - High-redundancy, upstream arrangement for safing sensor
 - · Squib short diagnosis
 - Squib drive MOSFET diagnosis
- Chip select function allows for multi-channel structure to be materialized using minimum control lines.
- Comes in a 24-pin SSOP surface mount package.
- Supports embossed taping.

Pin Assignment (top view)

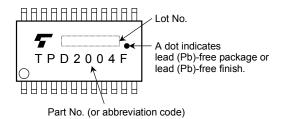


Note: Due to its MOS structure, this product is sensitive to static electricity.



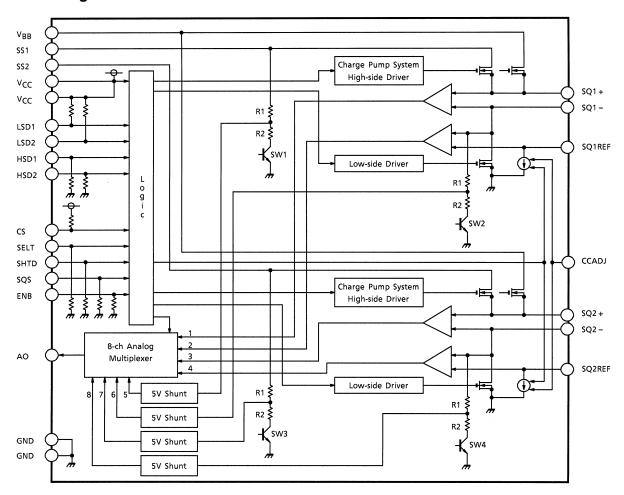
Weight: 0.29g (typ.)

Marking



2004-10-06

Block Diagram



Pin Description

Pin No.	Symbol	Pin Description
1	SQ1+	Squib positive (+) side output pin for channel 1
2	HSD1	High-side driver control input pin for Channel 1 (pull-down)
3	SS1	Safing sensor connect pin for channel 1
4	V _{BB}	Backup block power supply input pin
5	SHTD	Control input pin for short diagnosis (pull-down)
6	ENB	INHIBIT input pin to inhibit ignition when this input is pulled low (pull-down)
7	AO	Analog multiplexer output pin
8	LSD1	Low-side driver control input pin for Channel 1 (pull-up)
9	SELT	Control input pin for switching between diagnosis line and analog multiplexer (pull-down)
10	SQ1-	Squid negative (-) side output pin for channel 1 (shared with reference resistor pin for short diagnosis)
11	SQ1REF	Shorting diagnosis reference resistor pin for channel 1
12, 13	GND	Ground pin (Two pins)
14	SQ2REF	Shorting diagnosis reference resistor pin for Channel 2
15	SQ2-	Squib negative (-) side output pin for channel 2 (shared with reference resistor pin shorting diagnosis)
16	SQS	Squib switchover control input pin during each squib diagnosis (pull-down)
17	LSD2	Low-side driver control input pin for Channel 2 (pull-up)
18, 19	V _{CC}	5V block power supply input pin (two pins)
20	CS	Chip select control input pin (pull-up)
21	CCADJ	Current setup resistor connect pin for short diagnosis constant-current source (reference resistor connect pin)
22	SS2	Safing sensor connect pin for Channel 2
23	HSD2	High-side driver control input pin for Channel 2 (pull-down)
24	SQ2+	Squib positive (+) side output pin for Channel 2

Truth Table

State	SQUIB	HSD1	HSD2	LSD1	LSD2	SELT	SHTD	SQS	ENB	CS	MULTIP LEXER ch	DIVIDING VOLTAGE SW
Ignition	SQ1	Н	*	L	*	*	*	*	Н	*	_	_
ignition	SQ2	*	Н	*	L	*	*	*	Н	*	_	_
	SQ1	L	L	Н	Н	L	Н	L	Н	L	1	_
Short Diagnosis	SQ1	L	L	Н	Н	Н	Н	L	Н	L	2	_
Short Diagnosis	SQ2	L	L	Н	Н	L	Н	Н	Н	L	3	_
	SQ2	L	L	Н	Н	Н	Н	Η	Н	Ш	4	_
SS1 Potential Diagnosis (Not Divided)	SQ1	L	L	Н	Н	Н	Г	L	Г	L	5	-
SS2 Potential Diagnosis (Not Divided)	SQ2	L	L	Н	Н	Н	L	Н	L	L	7	_
SS1 Potential Diagnosis (Divided)	SQ1	L	L	Н	Н	Н	L	L	Н	L	5	SW1
SS2 Potential Diagnosis (Divided)	SQ2	L	L	Н	Н	Н	L	Н	Н	L	7	SW3
SQ-1 Potential Diagnosis (Not Divided)	SQ1	L	L	Н	Н	L	L	L	Н	L	6	_
SQ-2 Potential Diagnosis (Not Divided)	SQ2	L	L	Н	Н	L	L	Н	Н	L	8	_
SQ-1 Potential Diagnosis (Divided)	SQ1	L	L	Н	Н	L	L	L	L	L	6	SW2
SQ-2 Potential Diagnosis (Divided)	SQ2	L	L	Н	Н	L	L	Н	L	L	8	SW4
High-side Driver	SQ1	Н	L	Н	Н	L	L	L	Н	L	6	SW2
Diagnosis	SQ2	L	Н	Н	Н	L	L	Н	Н	L	8	SW4
Low-side Driver	SQ1	L	L	L	Н	L	L	L	Н	L	6	_
Diagnosis	SQ2	L	L	Н	L	L	L	Н	Н	L	8	_

*: Don't Care

Note: When ENB input is pulled low, ignition is inhibited.

Note: When CS is high, the diagnostic inputs SELT, SHTD, and SQS are ignored (in logic) and the AO pin is

placed in the high-impedance state.

Note: If ignited under shorted condition, the device may break down.

Functional Description

(1) 2-channel squib drive function

Using independent four-channel inputs, this IC controls two high-side and two low-side switches, making it possible to drive two squibs directly.

(2) Squib line short-to-battery, short-to-ground and open-circuit diagnostic function (diagnostic voltage output)

When the squib is in normal state, by an external diagnostic resistor, the device outputs a voltage derived from VCC by dividing it according to the resistance ratio. Because this voltage is output via the analog multiplexer, it is possible to diagnose short-to-battery, short-to-ground and open-circuit in the squib line using a microcomputer. Also, the device contains a shunt circuit to prevent the analog multiplexer from breaking down when the squib is short-to-battery.

(3) Squib short diagnostic function (diagnostic voltage output)

A diagnostic current is flowed from the internal constant-current source to the squib and reference resistor, and the voltage drop in each is amplified by an internal amp whose gain is the same for both. These voltages are output via the analog multiplexer, so that the squib resistance value can be diagnosed by a microcomputer. Also, the relative accuracy of the output voltages is guaranteed to be within $\pm 10\%$.

(4) Squib driver MOSFET diagnostic function (diagnostic voltage output)
When the squib driver is turned on while the safing sensor is in normal state, the drain voltage of the MOSFET is output via the analog multiplexer, making it possible to diagnose the state of the MOSFET using a microcomputer.

(5) Diagnostic chip select function

Since the device has a chip select function, the diagnostic control bits can be minimized when the application circuit is configured with multiple chips. Furthermore, when a chip is not selected, the diagnostic output pin AO is placed in the high-impedance state; therefore it is possible to diagnose multiple chips using a 1-channel CPU A/D port. (Ignition operates irrespective of CS.)

(6) Input INHIBIT function

The purpose of this function is to prevent erroneous ignition due to a fault in the microcomputer or the system power supply. It allows for ignition to be inhibited by pulling the ENB pin low.

Maximum Rating ($Ta = -40 \sim 85$ °C)

Characteristics	Symbol	Rating	Unit
Power Supply Voltage	V_{BB}	30	V
Tower Supply Voltage	V _{CC}	10	ľ
Input Voltage	SS	30	V
Input Voltage	V _{IN}	-0.5~7	v
Backup Capacitor Capacitance	СМ	1500 (1ch)	μF
Backup Capacitor Charging Voltage	CV	25	V
Squib ON-Time	t _{ON}	15	ms
Squib Driver Current (channel)	I _{SQ}	10	Α
Power Dissipation	P _D	0.8	W
Operating Temperature	T _{opr}	-40~85	°C
Junction Temperature	Tj	150	°C
Storage Temperature	T _{stg}	-55~150	°C

Note: The squib driver uses a 60V tolerant output device. However, this does not guarantee that the squib tolerates 60V because this varies with the withstand voltages of peripheral circuits.

Electrical Characteristics ($T_j = -40 \sim 85$ °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Operating Supply Voltage		V_{BB}	_	4	_	25	V	
		V _{CC}	_	4.75	_	5.25	_ v	
		I _{BB}	V_{BB} = 24V, when diagnosed, CCRef = 20k Ω	_	35	100		
Supply Current			V _{BB} = 24V, when not diagnosed	_	0.1	1	mA	
		I _{CC}	V _{CC} = 5.25V, when diagnosed	_	5	10		
			V _{CC} = 5.25V, when not diagnosed		3	6		
Innut Voltage		V _{IL}	INPUT "L"	1	I	V _{CC} × 0.3	V	
input voltage	Input Voltage		INPUT "H"	V _{CC} × 0.7	-	1	v	
		I	V _{IN} = 0V (Pull-down)	_	_	±10		
Input Current		l _{IL}	V _{IN} = 0V (Pull-up)	_	-50	-200	μА	
input Current		lін	V _{IN} = V _{CC} (Pull-down)	_	50	200		
			V _{IN} = V _{CC} (Pull-up)	_	_	±10		
Coult Date ON Desistance		R _{DS} (ON) SQ	V _{BB} = 9V, V _{CC} = 4.75V, I _D = 1A	_	0.6	1	Ω	
Squib Driver ON-Resis	Squib Driver ON-Resistance		V _{BB} = 9V, V _{CC} = 4.75V, I _D = 3A	_	0.7	1.2	72	
	High Side	I _{OLSQ (H)}	V _{OUT} = 25V	_	I	0.1	mA	
Squib Driver Output Leakage Current	Low Side	I _{OLSQ (L)}	V _{OUT} = V _{CC}		1	0.1		
,			V _{OUT} = 25V	_	I	1		
Diagnostic Amp Amplif	ication Factor	AMPGAIN	V_{CC} = 4.75V, AMPVCOMM = 3V, T_j = 25°C	18	20	22		
Diagnostic Amp Offset Voltage		AMPOFFSET	V_{CC} = 4.75V, AMPVCOMM = 3V, T_j = 25°C	ı	I	±10	mV	
Diagnostic Amp Differential Input Voltage Range		AMPVDEF	$V_{CC} = 4.75V$, $I_{SH} = 100$ mA, AMPVCOMM = 3V, $T_j = 25$ °C	200	l	I	mV	
Diagnostic Amp In-phase Input Voltage Range		AMPVCOMM	_	3.0	l	I	>	
Diagnostic Amp Output Saturation Voltage		V _{AMPSAT}	_	V _{CC} -1	_	_	V	
Diagnostic Constant-current Source		I _{SHDIAGCC}	CC _{Ref} = 20kΩ	28	35	45	mA	
Diagnostic Output Voltage		V _{DIAGSQ}	$R_{SQ} = 2\Omega$, $I_{SH} = 35$ mA, $I_{AO} = 5\mu$ A	900	1400	1900	mV	
		V _{DIAGREF}	R_{REF} = 2 Ω , I_{SH} = 35mA, I_{AO} = 5 μ A	900	1400	1900	IIIV	
Diagnostic Output Relative Accuracy		V _{DIAGDEV}	$R_{SQ} = R_{REF} = 2\Omega$, $I_{SH} = 35$ mA, $I_{AO} = 5\mu$ A	-10	0	10	%	

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Diagnostic Posistance	Value	R1	_	40	80	280	kΩ	
Diagnostic Resistance Value		R2	_	10	20	70	N32	
Diagnostic Voltage Div	iding Ratio	V _{DIV}	_	0.17	0.2	0.23	_	
Diagnostic Resistance Relative Accuracy		R _{DEV}	(Measured between SS1, SQ1-, SS2, SQ2-)	-5	0	5	%	
Switching Time (High-side SW)		T _{PLH}	V = 25V D l = 2A	_	100	200	.10	
		T _{PHL}		_	10	50		
Switching Time (Low-side SW)		T _{PLH}	V_{BB} = 25V, R_{load} , I_{D} = 3A	_	10	50	μs 50	
		T _{PHL}		_	10	50		
Diagnosis Switchover Time	High-side Driver Diagnosis	T _{DLH}	-V _{BB} = 25V, R _{load} , R = 2Ω	_	120	250		
		T _{DHL}		_	50	100		
	Low-side Driver Diagnosis	T _{DLH}		_	20	80		
		T _{DHL}		_	40	80	μs	
	Other Diagnosis	T _{DLH}		_	30	60		
		T _{DHL}		_	50	100		

Note: The short diagnosis monitor current in cases when the CCADJ pin is shorted to GND is 100mA (max) (at all

temperatures).

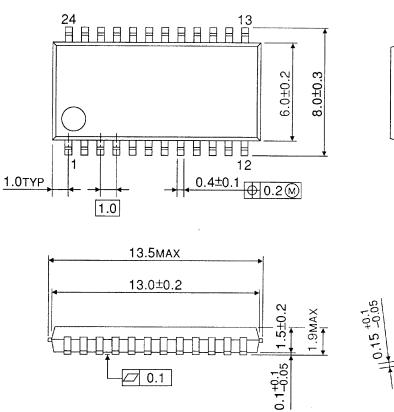
TOSHIBA

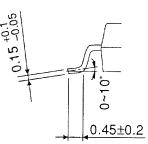
Note: Short diagnosis must be completed within 15ms.

Unit: mm

Package Dimensions

SSOP24-P-300-1.00C





7.62

Weight: 0.29g (typ.)

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